



UNITED STATES PATENT AND TRADEMARK OFFICE

Examiner: Christopher G. Webb

Art Unit: 2878

Re:

Application of:

Volker SEYFRIED

Serial No.:

10/601,804

Filed:

June 23, 2003

For:

METHOD FOR MICROSCOPY, AND

MICROSCOPE

Customer No.:

23280

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450 July 28, 2005

Sir:

In accordance with the provisions of 37 C.F.R. § 1.97, Applicant hereby makes of record the documents listed on the accompanying PTO-1449 Form (1 page) for consideration by the Examiner in connection with the examination of the above-identified patent application. While the references are being submitted herewith, some or all of the references may not constitute prior art under the U.S. patent laws.

A fee of \$180.00 under 37 C.F.R. § 1.17 (p) for submission of an Information Disclosure Statement is submitted herewith. If any additional fees are deemed to be due at this time, the Assistant Commissioner is authorized to charge payment of the same to Deposit Account No. 50-0552.

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It is respectfully requested that the references cited in the accompanying PTO-1449 form be considered and made of record. It is respectfully submitted that the pending claims are patentable over all of the references made of record at this time.

Respectfully Submitted,

DAVIDSON, DAVIDSON & KAPPEL, LLC

Bv:

Erik R. Swanson,

(Reg. No. 40,833)

Davidson, Davidson & Kappel, LLC 485 Seventh Avenue, 14th Floor New York, New York 10018 (212) 736-1940

FORM PTO (REV. 7-80)	-1449		U.S. DEPARTMENT OF COMME PATENT AND TRADEMARK OFF			ATTY DOCKET NO. 5005.1050			APPLICATION NO 10/601,804		
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